

PCTEST ENGINEERING LABORATORY, INC.

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HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics U.S.A, Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States Date of Testing: 07/08/2019 - 07/25/2019 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 1M1907050113-07.ZNF Date of Issue: 08/08/2019

FCC ID:

ZNFX120WM

APPLICANT:

LG ELECTRONICS U.S.A, INC.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard:

DUT Type: Model: Additional Model(s): Test Device Serial No.: RF Emissions Testing Certification CFR §20.19(b) ANSI C63.19-2011 285076 D01 HAC Guidance v05 285076 D02 T-Coil testing for CMRS IP v03 Portable Handset LM-X120WM LMX120WM, X120WM *Pre-Production Sample* [S/N: 04685]

C63.19-2011 HAC Category:

M3 (RF EMISSIONS CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested. North America bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. DUT DESCRIPTION



FCC ID: Manufacturer:

Model: Additional Model(s): Serial Number: Antenna Configurations: DUT Type: ZNFX120WM LG Electronics U.S.A, Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States LM-X120WM LMX120WM, X120WM 04685 Internal Antenna Portable Handset

 Table 2-1

 ZNFX120WM HAC Air Interfaces

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service
	850	vo	Yes	Yes: WIFI or BT	CMRS Voice
GSM	1900	10	163	Tes. WIT OF BI	civilis voice
	GPRS/EDGE	DT	No	Yes: WIFI or BT	N/A
	850				
UMTS	1700	VD	No ¹	Yes: WIFI or BT	CMRS Voice
010113	1900				
	HSPA	DT	No	Yes: WIFI or BT	N/A
	700 (B12)			1 Yes: WIFI or BT	Volte
	700 (B17)				
	780 (B13)		No ¹		
LTE (FDD)	850 (B5)	VD			
	1700 (B4)				
	1700 (B66)				
	1900 (B2)				
WIFI	2450	DT	No	Yes: GSM, UMTS, or LTE	N/A
BT	2450	DT	No	Yes: GSM, UMTS, or LTE	N/A
VO = Voice Only DT = Digital Dat	Type Transport Notes: VO = Voice Only 1. Evaluated for MIF and low-power exemption. DT = Digital Data - Not intended for Voice Services VD = CMRS and/or IP Voice over Data Transport				

I. LTE Band Selection

This device supports the following pairs of LTE bands with similar frequencies: LTE B12 & B17 and B66 & B4. These pairs of LTE bands have the same target powers and share the same transmission paths. Since the supported frequency span for the smaller LTE bands are completely covered by the larger LTE bands, only the larger LTE bands (LTE B12 and B66) were evaluated for hearing-aid compliance.

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3. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters				
Near field Category	E-field emissions CW dB(V/m)				
	f < 960 MHz				
M1	50 to 55				
M2	45 to 50				
M3	40 to 45				
M4	< 40				
	f > 960 MHz				
M1	40 to 45				
M2	35 to 40				
M3	30 to 35				
M4	< 30				
Table 3-1WD near-field categories as defined in ANSI C63.19-2011					

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4. SYSTEM SPECIFICATIONS

EF3DV3 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis
Calibration:	Built-in shielding against static charges In air from 30 MHz to 6.0 GHz (absolute accuracy ±5.1%, k=2)
Frequency:	30 MHz to > 6 GHz;
	Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis)
	± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m
, ,	(M3 or better device readings fall well below diode
	compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 337 mm (Tip: 20 mm)
	Tip diameter: 4.0 mm (Body: 12 mm)
	Distance from probe tip to dipole centers: 1.5 mm

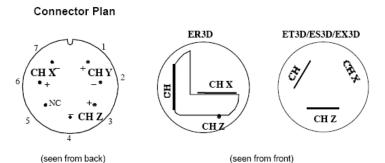


Figure 4-1 E-field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement").



The antistatic shielding inside the probe is connected to the probe connector case.

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Instrumentation Chain

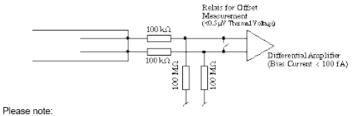
Equation 1 Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

Ei:	electric field in V/m
Uj.	voltage of channel i at the connector in μV
Norm	sensitivity of channel i in µV/(V/m) ²
ConvF:	enhancement factor in liquid (ConvF=1 for Air)
DCP:	diode compression point in µV
CF:	signal crest factor (peak power/average power)

Conditions of Calibration



a lower input impedance of the amplifier will result in different sensitivity factors Norm, and DCP

larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

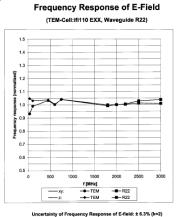


Figure 4-2 E-Field Probe Frequency Response

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SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 4-3 SPEAG Robotic System

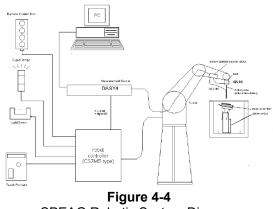
System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with	V_i	= compensated signal of channel i	(i = x, y, z)
	U_i	= input signal of channel i	(i = x, y, z)
	cf	= crest factor of exciting field	(DASY parameter)
	dcp_i	= diode compression point	(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

E – fieldprobes :
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

with
$$V_i$$
 = compensated signal of channel i (i = x, y, z)
 $Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
 $\mu V/(V/m)^2$ for E-field Probes
 $ConvF$ = sensitivity enhancement in solution
 E_i = electric field strength of channel i in V/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

Environmental Conditions

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

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5. TEST PROCEDURE

I. RF EMISSIONS

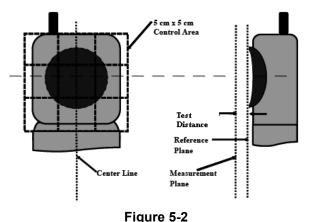
Test Instructions Confirm proper operation of ≻ probes and instrumentation Position WD \succ **Configure WD TX operation** ≻ Per 5.5.1.2 (a-c) Initialize field probe ⋟ Scan Area ≻ Per 5.5.1.2 (d-f) Identify exclusion area. \geq \geq Rescan or reanalyze open area to determine maximum Indirect method: Add the MIF \geq to the maximum steady state rms field strength and record **RF** Audio Interference Level, in dB(V/m) Per 5.5.1.2 (g-h) & 5.5.1.3 Identify and record the ≻ category Per 5.5.1.2 (i-j)

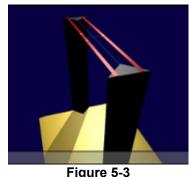
Figure 5-1 RF Emissions Flow Chart

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Test Setup





HAC Phantom

E-Field Emissions Test Setup Diagram (See Test Photographs for actual WD scan grid overlay)

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- 3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- 4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- 6. The measurement system measured the field strength at the reference location.
- 7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. Of the 9 subgrids (see Figure 5-2), 3 contiguous subgrids may be excluded from the measurement in order to account for localized areas of higher field intensities. The center subgrid containing the acoustic output or audio band magnetic output may not excluded. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 8. The system performed a drift evaluation by measuring the field at the reference location. If the power drift deviated by more than 5%, the HAC test and drift measurements were repeated.

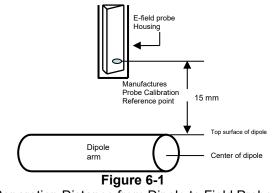
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6. SYSTEM CHECK

I. System Check Parameters

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 15 mm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device [e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (20dBm) RMS] after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

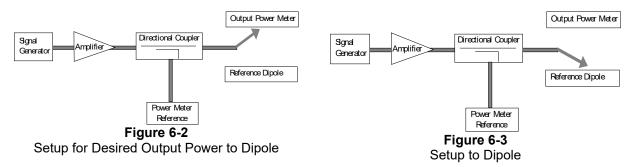
The length of the dipole was scanned, and the average peak value was recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

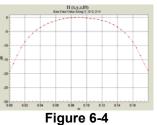
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RF power was recorded using both an average and a peak power reading meter.

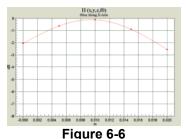


Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 6-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:



2-D Raw Data from scan along dipole axis



2-D Raw Data from scan along transverse axis



2-D Interpolated points from scan along dipole axis

				100						
			100					~		
		1						-	N	
	1								-	
	· · ·									~
		-						-	-	
-	-	-	-	-	-	-	-	-	-	
-	-	-	-	-	-	-	-	-	-	

Figure 6-7 2-D Interpolated points from scan along transverse axis

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III. System Check Results

Validation Results

Date	Frequency (MHz)	Probe S/N	DAE S/N	Dipole S/N	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
7/8/2019	835	4035	1415	1003	20.0	107.7	105.2	2.3%
7/22/2019	1880	4035	1415	1137	20.0	88.4	87.8	0.6%

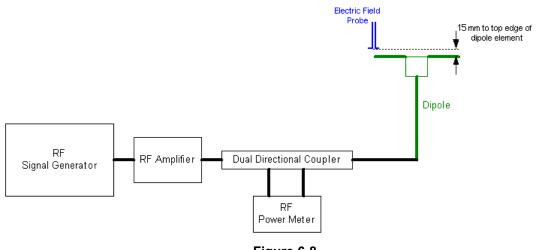


Figure 6-8 System Check Setup

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7. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

- a. Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- b. Measure the steady-state RMS level at the output of the fast probe or sensor.
- c. Measure the steady-state average level at the weighting output.
- d. Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
- e. Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
- f. The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB (20 × log[(step e)/(step b)]).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Serial No.: 1010:

- 1. The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
- 2. The device was then set to continuously transmit at maximum power.
- 3. Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
- 4. The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
- 5. Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

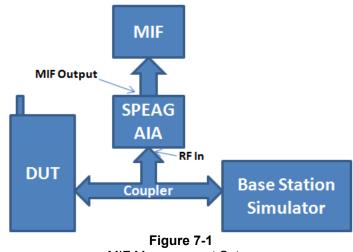
The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

Audio Interference Level [dB(V/m)] = 20 * log[Raw Field Value (V/m)] + MIF (dB)

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The voice modes for this device have been investigated in this section of the report.

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II. MIF Measurement Block Diagrams



MIF Measurement Setup for licensed modes

III. Measured Modulation Interference Factors:

	Table 7-1 GSM Modulation Interference Factors ¹										
M	GSM850 GSM1900										
IVIC	ode	128	128 190 251			661	810				
GSM	GSM Voice		3.47	3.48	3.53	3.53	3.53				

Table	7-2
-------	-----

UMTS Modulation Interference Factors¹

Mode			UMTS V		UMTS IV			UMTS II		
		4132	4183	4233	1312	1412	1513	9262	9400	9538
LIMTE	12.2 kbps RMC	-11.92	-11.88	-12.08	-12.06	-12.04	-11.98	-11.93	-11.93	-11.82
UMTS	12.2 kbps AMR	-13.23	-13.04	-12.78	-12.92	-12.88	-13.11	-12.86	-12.76	-12.79

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

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LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
66	1745.0	132322	20	16QAM	1	0	-9.69
2	1880.0	18900	20	16QAM	1	0	-10.08
12	707.5	23095	10	16QAM	1	0	-9.73
13	782.0	23230	10	16QAM	1	0	-10.64
5	836.5	20525	10	16QAM	1	0	-9.99
66	1745.0	132322	20	QPSK	1	0	-15.28
66	1745.0	132322	20	16QAM	1	50	-10.03
66	1745.0	132322	20	16QAM	1	99	-10.01
66	1745.0	132322	20	16QAM	50	0	-16.44
66	1745.0	132322	20	16QAM	100	0	-17.81
66	1745.0	132322	15	16QAM	1	0	-9.72
66	1745.0	132322	10	16QAM	1	0	-9.75
66	1745.0	132322	5	16QAM	1	0	-9.57
66	1745.0	132322	3	16QAM	1	0	-9.75
66	1745.0	132322	1.4	16QAM	1	0	-10.60
66	1712.5	131997	5	16QAM	1	0	-9.73
66	1777.5	132647	5	16QAM	1	0	-10.82

 Table 7-3

 LTE FDD Modulation Interference Factors^{1,2}

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: All FDD LTE bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

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RF CONDUCTED POWER MEASUREMENTS 8.

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was placed into a simulated call using a base station simulator in a shielded chamber. Such test signals offer a consistent means for testing HAC and are recommended for evaluating HAC. Measurements were taken with a fully charged battery. In order to verify that the device was tested and maintained at full power, this was configured with the base station simulator.

II. HAC Measurement Conditions

Output Power Verification

Maximum output power is verified on the High, Middle and Low channels for all applicable air interfaces. See Table 8-1 for air interface specific settings of transmit power parameters.

Table 8-1 Power Control Parameters and Settings by Air Interface									
Air Interface:	Air Interface: Parameter Name: Parameter Set To:								
GSM	PCL	GSM850: "5"; GSM1900: "0"							
UMTS	TPC	"All 1's"							
LTE	LTE TPC "Max Power"								

III. Setup Used to Measure RF Conducted Powers

Power measurements for licensed modes were performed using a base station simulator under digital average power.



Figure 8-1 Power Measurement Setup for licensed modes

IV. GSM Conducted Powers

Band	Channel	GSM [dBm] CS (1 Slot)
	128	33.38
GSM 850	190	33.32
	251	33.34
	512	30.37
GSM 1900	661	30.39
	810	30.30

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V. UMTS Conducted Powers

Mode	3GPP 34.121	Cellular Band [dBm]		AWS Band [dBm]			PCS Band [dBm]			
	Subtest	4132	4183	4233	1312	1412	1513	9262	9400	9538
WCDMA	12.2 kbps RMC	24.01	24.02	24.04	23.02	23.11	23.20	22.68	22.61	22.50
W CDIVIA	12.2 kbps AMR	24.03	24.06	24.05	23.10	23.12	23.23	22.73	22.56	22.61

VI. LTE Conducted Powers

a. LTE Band 12

C											
				Table 8-2							
	LTE Bai	nd 12 (70)7.5MHz)	Conducted P	owers – 10MH	z Bandwidth					
				Mid Channel							
	Modulation	RB Size	RB Offset	23095 (707.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]					
				Conducted Power [dBm]							
		1	0	24.00		0					
		1	25	24.16	0	0					
		1	49	23.96		0					
	QPSK	25	0	22.92		1					
		25	12	22.91	0-1	1					
		25	25	22.90	0-1	1					
		50	0	22.89		1					
		1	0	23.28		1					
		1	25	23.35	0-1	1					
		1	49	23.24	1	1					
	16QAM	25	0	21.97		2					
		25	12	21.96	0-2	2					
		25	25	21.91	0-2	2					
		50	0	21.94	1	2					

Note: Since LTE Band 12 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

		LTE Band	12 (707.5MHz) Conducted P	owers – 5MHz	Bandwidth	
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23035 (701.5 MHz)	23095 (707.5 MHz)	23155 (713.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	23.82	23.89	23.85		0
	1	12	24.14	24.18	24.19	0	0
	1	24	23.89	23.95	23.95		0
QPSK	12	0	22.98	22.95	22.98	0-1	1
	12	6	23.00	23.04	23.00		1
	12	13	23.11	23.02	22.92		1
	25	0	23.03	23.02	23.01		1
	1	0	23.02	23.09	23.13		1
	1	12	23.28	23.21	23.44	0-1	1
	1	24	23.03	23.09	23.19		1
16QAM	12	0	21.98	21.97	22.00		2
	12	6	22.10	22.06	22.01	0-2	2
	12	13	22.06	22.10	21.91	0-2	2
	25	0	22.01	22.02	21.96		2

Table 8-3
LTE Band 12 (707.5MHz) Conducted Powers – 5MHz Bandwidth

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			1 1 Z (1 0 1 . 5 WH 1 Z) oonaactea i		Danawiath	
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size RB Offse	RB Offset	23025 (700.5 MHz)	23095 (707.5 MHz)	23165 (714.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			c	Conducted Power [dBm	1]		
	1	0	23.94	23.98	24.01		0
	1	7	24.12	24.13	24.10	0	0
	1	14	23.93	23.99	23.98	1	0
QPSK	8	0	23.04	23.06	23.00		1
	8	4	23.10	22.99	23.07	0-1	1
	8	7	23.04	23.03	22.98	0-1	1
	15	0	23.02	23.01	22.99		1
	1	0	23.11	23.11	23.40		1
	1	7	23.31	23.20	23.50	0-1	1
	1	14	23.13	23.07	23.34		1
16QAM	8	0	22.06	21.98	22.06		2
	8	4	22.08	22.04	22.11	0-2	2
	8	7	22.05	21.97	22.08	0-2	2
	15	0	21.94	22.02	22.02	1	2

Table 8-4 LTE Band 12 (707.5MHz) Conducted Powers – 3MHz Bandwidth

Table 8-5

LTE Band 12 (707.5MHz) Conducted Powers – 1.4MHz Bandwidth

			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23017 (699.7 MHz)	23095 (707.5 MHz)	23173 (715.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	24.13	23.92	24.05		0
	1	2	24.23	24.01	24.11		0
	1	5	24.11	24.06	24.06	0	0
QPSK	3	0	24.13	24.15	24.04		0
	3	2	24.15	24.11	24.07]	0
	3	3	24.14	24.13	24.02		0
	6	0	23.30	23.11	23.21	0-1	1
	1	0	22.90	23.14	22.80		1
	1	2	23.00	23.25	22.87		1
	1	5	22.93	23.15	22.91	0-1	1
16QAM	3	0	23.10	22.96	23.01	0-1	1
	3	2	23.14	22.95	22.99		1
	3	3	23.14	22.96	23.00		1
	6	0	22.26	22.14	22.20	0-2	2

b. LTE Band 13

			Table 8-6								
LTE Band 13 (782.0MHz) Conducted Powers – 10MHz Bandwidth											
			Mid Channel								
Modulation	RB Size	RB Offset	23230 (782.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]						
			Conducted Power [dBm]								
	1	0	24.20		0						
	1	25	24.16	0	0						
	1	49	24.14		0						
QPSK	25	0	23.00		1						
	25	12	23.04	0-1	1						
	25	25	23.02	0-1	1						
	50	0	23.00		1						
	1	0	23.50		1						
	1	25	23.49	0-1	1						
	1	49	23.35		1						
16QAM	25	0	22.05		2						
	25	12	22.09	0-2	2						
	25	25	22.06	0-2	2						
	50	0	21.99		2						

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LIE Band 13 (782.0MHZ)			Conducted F	'owers – 5MH	z Bandwidth		
			Mid Channel				
Modulation	RB Size	RB Size	RB Size	RB Offset	Offset 23230 (782.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power				
			[dBm]				
	1	0	24.16		0		
	1	12	24.19	0	0		
	1	24	24.17		0		
QPSK	12	0	23.05		1		
	12	6	23.04	0-1	1		
	12	13	23.04	0-1	1		
	25	0	23.04		1		
	1	0	23.19		1		
	1	12	23.29	0-1	1		
	1	24	23.07		1		
16QAM	12	0	22.05		2		
	12	6	22.08	0-2	2		
	12	13	22.06] 0-2	2		
-	25	0	21.99		2		

 Table 8-7

 LTE Band 13 (782.0MHz) Conducted Powers – 5MHz Bandwidth

Note: Since LTE Band 13 at 5MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

c. LTE Band 5

			Table 8-8								
LTE Band 5 (836.5MHz) Conducted Powers – 10MHz Bandwidth											
			Mid Channel								
Modulation	RB Size	RB Offset	20525 (836.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]						
			Conducted Power [dBm]								
	1	0	24.04		0						
	1	25	24.18	0	0						
	1	49	24.04		0						
QPSK	25	0	23.15		1						
	25	12	23.20	0-1	1						
	25	25	23.15	0-1	1						
	50	0	23.15		1						
	1	0	23.35		1						
	1	25	23.50	0-1	1						
	1	49	23.49		1						
16QAM	25	0	22.12		2						
	25	12	22.14	0-2	2						
	25	25	22.13	0-2	2						
	50	0	22.13		2						

Note: Since LTE Band 5 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

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			Low Channel	Mid Channel	High Channel				
Modulation	RB Size RB Of	RB Offset	20425 (826.5 MHz)	20525 (836.5 MHz)	20625 (846.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]		
			(Conducted Power [dBm]	1			
	1	0	24.08	24.15	24.05		0		
	1	12	24.35	24.45	24.30	0	0		
	1	24	24.10	24.09	24.00		0		
QPSK	12	0	23.17	23.24	23.17		1		
	12	6	23.27	23.28	23.16	0-1	1		
	12	13	23.21	23.17	23.09	0-1	1		
	25	0	23.22	23.24	23.14		1		
	1	0	23.25	23.34	23.25		1		
	1	12	23.50	23.50	23.45	0-1	1		
	1	24	23.24	23.22	23.09		1		
16QAM	12	0	22.16	22.25	22.18		2		
	12	6	22.27	22.30	22.18	0-2	2		
	12	13	22.21	22.22	22.11	0-2	2		
	25	0	22.16	22.20	22.09		2		

Table 8-9 LTE Band 5 (836.5MHz) Conducted Powers – 5MHz Bandwidth

Table 8-10

LTE Band 5 (836.5MHz) Conducted Powers – 3MHz Bandwidth

Modulation RB Size	RB Offset	Low Channel 20415	Mid Channel 20525	High Channel 20635	MPR Allowed per	MPR [dB]	
			(825.5 MHz)	(836.5 MHz)	(847.5 MHz)	3GPP [dB]	
			(Conducted Power [dBm]		
	1	0	24.19	24.26	24.11		0
	1	7	24.38	24.45	24.24	0	0
	1	14	24.20	24.21	24.09		0
QPSK	8	0	23.20	23.25	23.13		1
	8	4	23.26	23.27	23.17	0-1	1
	8	7	23.23	23.23	23.12	0-1	1
	15	0	23.21	23.25	23.15		1
	1	0	23.33	23.46	23.50		1
	1	7	23.50	23.50	23.41	0-1	1
	1	14	23.45	23.46	23.29		1
16QAM	8	0	22.21	22.26	22.13		2
	8	4	22.24	22.30	22.17	0.2	2
	8	7	22.23	22.25	22.13	0-2	2
	15	0	22.15	22.18	22.10		2

Table 8-11

LTE Band 5 (836.5MHz) Conducted Powers – 1.4MHz Bandwidth

Modulation RB S	RB Size	RB Offset	Low Channel 20407 (824.7 MHz)	Mid Channel 20525 (836.5 MHz)	High Channel 20643 (848.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	, <u>, , , , , , , , , , , , , , , , , , </u>	1	
	1	0	24.11	24.17	24.00		0
	1	2	24.23	24.23	24.17		0
	1	5	24.12	24.12	24.02	_	0
QPSK	3	0	24.18	24.22	24.10	0	0
	3	2	24.19	24.23	24.14	•	0
	3	3	24.17	24.20	24.09		0
	6	0	23.20	23.24	23.15	0-1	1
	1	0	23.29	23.44	23.16		1
	1	2	23.43	23.50	23.38		1
	1	5	23.30	23.33	23.17	0.1	1
16QAM	3	0	23.24	23.31	23.18	0-1	1
	3	2	23.26	23.35	23.18	1	1
	3	3	23.22	23.29	23.19		1
	6	0	22.21	22.26	22.16	0-2	2

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d. LTE Band 66

LTE Band 66 (1745.0MHZ) Conducted Powers – 20MHZ Bandwidth											
			Low Channel	Mid Channel	High Channel						
Modulation	RB Size	RB Offset	132072 (1720.0 MHz)	132322 (1745.0 MHz)	132572 (1770.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]				
			(Conducted Power [dBm]						
	1	0	23.04	23.23	23.33		0				
	1	50	23.40	23.50	23.49	0	0				
	1	99	23.13	23.18	23.25		0				
QPSK	50	0	22.44	22.48	22.49		1				
	50	25	22.46	22.50	22.40	0-1	1				
	50	50	22.49	22.45	22.37		1				
	100	0	22.40	22.47	22.35		1				
	1	0	22.40	22.47	22.40		1				
	1	50	22.50	22.49	22.50	0-1	1				
	1	99	22.48	22.36	22.30		1				
16QAM	50	0	21.49	21.45	21.48		2				
	50	25	21.50	21.50	21.35	0-2	2				
	50	50	21.50	21.45	21.48	0-2	2				
	100	0	21.47	21.45	21.30		2				

Table 8-12 I TE Band 66 (1745 0MHz) Conducted Powers - 20MHz Bandwidth

Table 8-13

LTE Band 66 (1745.0MHz) Conducted Powers – 15MHz Bandwidth

Modulation	RB Size	RB Offset	Low Channel 132047 (1717.5 MHz)	Mid Channel 132322 (1745.0 MHz)	High Channel 132597 (1772.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	23.40	23.34	23.10		0
	1	36	23.47	23.41	23.18	0	0
	1	74	23.45	23.22	23.01		0
QPSK	36	0	22.50	22.43	22.35		1
	36	18	22.37	22.42	22.28	0-1	1
	36	37	22.35	22.50	22.28	0-1	1
	75	0	22.39	22.43	22.31		1
	1	0	22.43	22.50	22.42		1
	1	36	22.50	22.50	22.44	0-1	1
	1	74	22.48	22.50	22.28		1
16QAM	36	0	21.33	21.50	21.33		2
	36	18	21.38	21.49	21.26	0-2	2
	36	37	21.41	21.48	21.27	0-2	2
	75	0	21.36	21.49	21.28		2

Table 8-14 LTE Band 66 (1745.0MHz) Conducted Powers – 10MHz Bandwidth

			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	132022 (1715.0 MHz)	132322 (1745.0 MHz)	132622 (1775.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm			
	1	0	23.47	23.40	23.16		0
	1	25	23.40	23.46	23.20	0	0
	1	49	23.50	23.29	23.07		0
QPSK	25	0	22.47	22.34	22.30	0-1	1
	25	12	22.46	22.33	22.28		1
	25	25	22.50	22.33	22.30		1
	50	0	22.49	22.35	22.32		1
	1	0	22.50	22.40	22.44		1
	1	25	22.48	22.44	22.50	0-1	1
	1	49	22.42	22.31	22.40		1
16QAM	25	0	21.33	21.50	21.27		2
	25	12	21.35	21.49	21.24	0-2	2
	25	25	21.35	21.48	21.27	0-2	2
	50	0	21.38	21.49	21.29		2

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			Low Channel	Mid Channel	High Channel							
Modulation	RB Size	RB Offset	131997 (1712.5 MHz)	132322 (1745.0 MHz)	132647 (1777.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]					
			(Conducted Power [dBm]							
	1	0	23.03	23.08	23.04		0					
	1	12	23.32	23.30	23.31	0	0					
	1	24	23.00	23.02	23.00		0					
QPSK	12	0	22.21	22.22	22.12	0-1	1					
	12	6	22.25	22.26	22.26		1					
	12	13	22.20	22.20	22.18		1					
	25	0	22.23	22.26	22.23		1					
	1	0	22.36	22.40	22.38		1					
	1	12	22.47	22.34	22.49	0-1	1					
	1	24	22.26	22.28	22.30		1					
16QAM	12	0	21.24	21.27	21.25	0-2	2					
	12	6	21.27	21.26	21.29		2					
	12	13	21.23	21.34	21.22		2					
	25	0	21.20	21.27	21.20		2					

Table 8-15 LTE Band 66 (1745.0MHz) Conducted Powers – 5MHz Bandwidth

Table 8-16

LTE Band 66 (1745.0MHz) Conducted Powers – 3MHz Bandwidth

			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	131987 (1711.5 MHz)	132322 (1745.0 MHz)	132657 (1778.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	23.50	23.45	23.12		0
	1	7	23.46	23.43	23.25	0	0
	1	14	23.50	23.36	23.10	0-1	0
QPSK	8	0	22.40	22.47	22.23		1
	8	4	22.43	22.50	22.24		1
	8	7	22.41	22.47	22.22		1
	15	0	22.40	22.47	22.22		1
	1	0	22.49	22.49	22.42		1
	1	7	22.48	22.41	22.50	0-1	1
	1	14	22.35	22.45	22.41		1
16QAM	8	0	21.41	21.50	21.25		2
	8	4	21.35	21.50	21.27	0-2	2
	8	7	21.49	21.49	21.24		2
	15	0	21.44	21.42	21.16		2

Table 8-17 LTE Band 66 (1745.0MHz) Conducted Powers – 1.4MHz Bandwidth

			·				
			Low Channel	Mid Channel	High Channel		
Modulation RB	RB Size	RB Size RB Offset	131979 (1710.7 MHz)	132322 (1745.0 MHz)	132665 (1779.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm			
	1	0	23.43	23.30	23.04		0
	1	2	23.50	23.44	23.16	0	0
	1	5	23.42	23.30	23.00		0
QPSK	3	0	23.48	23.37	23.10		0
	3	2	23.50	23.37	23.13		0
	3	3	23.49	23.37	23.09		0
	6	0	22.50	22.46	22.20	0-1	1
	1	0	22.49	22.46	22.38		1
	1	2	22.50	22.44	22.50		1
	1	5	22.44	22.50	22.32	0-1	1
16QAM	3	0	22.40	22.35	22.30	0-1 	1
	3	2	22.40	22.30	22.36		1
	3	3	22.36	22.33	22.30		1
	6	0	21.34	21.30	21.25	0-2	2

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e. LTE Band 2

LTE Band 2 (1880.0MH2) Conducted Powers – 20MH2 Bandwidth											
Modulation	RB Size	RB Offset	Low Channel 18700 (1860.0 MHz)	Mid Channel 18900 (1880.0 MHz)	High Channel 19100 (1900.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]				
			(Conducted Power [dBm							
	1	0	24.04	24.05	24.27		0				
	1	50	24.30	24.44	24.50	0	0				
	1	99	24.02	24.13	24.41		0				
QPSK	50	0	23.31	23.24	23.49		1				
	50	25	23.36	23.29	23.42	0-1	1				
	50	50	23.37	23.30	23.39		1				
	100	0	23.30	23.29	23.40		1				
	1	0	23.48	23.22	23.43		1				
	1	50	23.50	23.50	23.50	0-1	1				
	1	99	23.40	23.28	23.49		1				
16QAM	50	0	22.29	22.21	22.39		2				
	50	25	22.34	22.27	22.37	0-2	2				
	50	50	22.32	22.23	22.37		2				
	100	0	22.31	22.26	22.38		2				

Table 8-18 LTE Band 2 (1880.0MHz) Conducted Powers – 20MHz Bandwidth

Table 8-19

LTE Band 2 (1880.0MHz) Conducted Powers – 15MHz Bandwidth

Modulation	RB Size	RB Offset	Low Channel 18675 (1857.5 MHz)	Mid Channel 18900 (1880.0 MHz)	High Channel 19125 (1902.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	24.23	24.07	24.15		0
	1	36	24.28	24.20	24.44	0	0
	1	74	24.14	24.10	24.30		0
QPSK	36	0	23.35	23.25	23.40		1
	36	18	23.32	23.25	23.38	0-1	1
	36	37	23.33	23.25	23.43	0-1	1
	75	0	23.35	23.28	23.43		1
	1	0	23.41	23.20	23.30		1
	1	36	23.46	23.27	23.50	0-1	1
	1	74	23.29	23.19	23.40		1
16QAM	36	0	22.42	22.29	22.35		2
	36	18	22.39	22.30	22.34	0-2	2
	36	37	22.39	22.32	22.39	0-2	2
	75	0	22.39	22.30	22.36		2

Table 8-20 LTE Band 2 (1880.0MHz) Conducted Powers - 10MHz Bandwidth

			- (
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18650 (1855.0 MHz)	18900 (1880.0 MHz)	19150 (1905.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	24.32	24.18	24.31		0
	1	25	24.39	24.26	24.39	0	0
	1	49	24.25	24.16	24.42		0
QPSK	25	0	23.42	23.30	23.46	0-1	1
	25	12	23.34	23.26	23.42		1
	25	25	23.42	23.31	23.50		1
	50	0	23.43	23.32	23.48		1
	1	0	23.48	23.35	23.47		1
	1	25	23.47	23.37	23.48	0-1	1
	1	49	23.43	23.33	23.44		1
16QAM	25	0	22.45	22.29	22.39		2
	25	12	22.40	22.30	22.35	0-2	2
	25	25	22.46	22.32	22.42	0-2	2
	50	0	22.45	22.33	22.39		2

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	-		~ (1000.0101112)	oonaactea i v		Bunamath	
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18625 (1852.5 MHz)	18900 (1880.0 MHz)	19175 (1907.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	24.22	24.08	24.23		0
	1	12	24.45	24.34	24.46	0	0
	1	24	24.16	24.06	24.28		0
QPSK	12	0	23.32	23.18	23.37		1
	12	6	23.37	23.24	23.42	0-1	1
	12	13	23.29	23.17	23.41	0-1	1
	25	0	23.37	23.22	23.41		1
	1	0	23.37	23.28	23.43		1
	1	12	23.49	23.47	23.50	0-1	1
	1	24	23.33	23.20	23.34		1
16QAM	12	0	22.42	22.27	22.36		2
	12	6	22.48	22.31	22.40	0-2	2
	12	13	22.39	22.30	22.37	0-2	2
	25	0	22.39	22.23	22.33		2

Table 8-21 LTE Band 2 (1880.0MHz) Conducted Powers – 5MHz Bandwidth

Table 8-22

LTE Band 2 (1880.0MHz) Conducted Powers – 3MHz Bandwidth

			Low Channel	Mid Channel	High Channel					
Modulation	RB Size	RB Offset	18615 (1851.5 MHz)	18900 (1880.0 MHz)	19185 (1908.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]			
			(Conducted Power [dBm]					
	1	0	24.30	24.18	24.35		0			
	1	7	24.48	24.32	24.45	0	0			
	1	14	24.26	24.17	24.39		0			
QPSK	8	0	23.33	23.20	23.38		1			
	8	4	23.36	23.22	23.44	0-1	1			
	8	7	23.33	23.19	23.42	0-1	1			
	15	0	23.34	23.22	23.46		1			
	1	0	23.45	23.30	23.50		1			
	1	7	23.49	23.44	23.50	0-1	1			
	1	14	23.50	23.33	23.44		1			
16QAM	8	0	22.44	22.28	22.37		2			
	8	4	22.47	22.30	22.40	0-2	2			
	8	7	22.44	22.28	22.37	0-2	2			
	15	0	22.37	22.22	22.35		2			

Table 8-23 LTE Band 2 (1880.0MHz) Conducted Powers – 1.4MHz Bandwidth

			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18607 (1850.7 MHz)	18900 (1880.0 MHz)	19193 (1909.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	24.32	24.16	24.38		0
	1	2	24.44	24.29	24.50		0
	1	5	24.30	24.15	24.39	0	0
QPSK	3	0	24.38	24.25	24.48	0	0
	3	2	24.42	24.27	24.50		0
	3	3	24.37	24.26	24.47		0
	6	0	23.40	23.28	23.50	0-1	1
	1	0	23.46	23.31	23.44		1
	1	2	23.50	23.44	23.50		1
	1	5	23.47	23.27	23.32	0-1	1
16QAM	3	0	23.46	23.29	23.44	0-1	1
	3	2	23.48	23.30	23.48		1
	3	3	23.46	23.30	23.45		1
	6	0	22.42	22.36	22.45	0-2	2

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9. JUSTIFICATION OF HELD TO EAR MODES TESTED

I. Analysis of RF Air Interface Technologies

An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst-case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17dBm for all of its operating modes. RF air interface technologies exempted from testing in this manner are automatically assigned an M4 rating to be used in determining the overall rating for the WD.

The worst-case MIF plus the worst-case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

Max Power + MIF calculati Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required
GSM850 GSM1900	24.35* 21.36*	3.48 3.53	27.83 24.89	Yes
UMTS - RMC	24.04	-11.82	12.22	No
UMTS - AMR	24.06	-12.76	11.30	No
LTE - FDD	24.50	-9.57	14.93	No

Table 9-1

- ---

II. Individual Mode Evaluations

* Note: ANSI C63.19-2011 Sec. 4.4 Footnote 20 indicates the use of a long averaging time for measuring the antenna input power when using this method of exclusion. Therefore, the frame averaged power was calculated for these modes in this investigation.

III. Low-Power Exemption Conclusions

Per ANSI C63.19-2011, RF Emissions testing for this device is required only for GSM voice modes. All other air interfaces are exempt.

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OVERALL MEASUREMENT SUMMARY 10.

FCC ID:	ZNFX120WM
S/N:	04685

I. E-FIELD EMISSIONS:

			Н	AC Data	Summa	ry for G	SM E-fiel	d			
Mode	Channel	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissio	ons										
	128	Acoustic	33.38	59.15	35.44	3.47	38.91	45.00	-6.09	M4	none
GSM850	190	Acoustic	33.32	54.62	34.75	3.47	38.22	45.00	-6.78	M4	none
	251	Acoustic	33.34	53.81	34.62	3.48	38.10	45.00	-6.90	M4	none
	512	Acoustic	30.37	27.82	28.89	3.53	32.42	35.00	-2.58	M3	none
GSM1900	661	Acoustic	30.39	27.30	28.72	3.53	32.25	35.00	-2.75	M3	none
G3W1900	810	Acoustic	30.30	25.16	28.01	3.53	31.54	35.00	-3.46	M3	none
	512	T-Coil	30.37	29.25	29.32	3.53	32.85	35.00	-2.15	M3	none



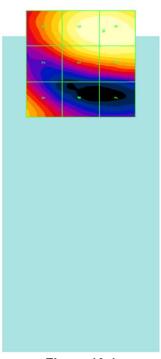


Figure 10-1 Sample E-field Scan Overlay (T-Coil Centered scan area pictured. See Test Setup Photographs for actual WD overlay and Acoustic Centered scan)

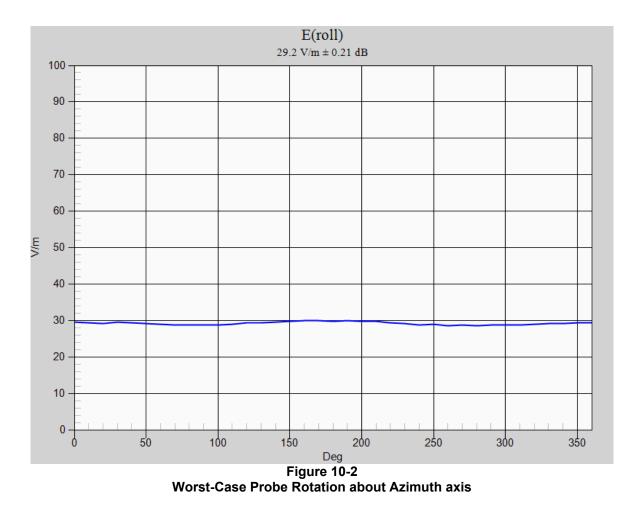
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II. Worst-case Configuration Evaluation

		Pea	ak Readir	1g 360° P	robe Rot	ation at A	zimuth a	xis		
Mode	Channel	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
Probe Rotation	Probe Rotation at Worst-Case									
GSM1900	512	T-Coil	29.97	29.53	3.53	33.06	35.00	-1.94	M3	none

Table 10-2



* Note: Locations of probe rotation (with and without exclusions) are shown in Figure 10-1 denoted by the green square markers.

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11. EQUIPMENT LIST

Manufacturer Model Description Cal Date Cal Interval Cal Due Serial Number Agilent N5182A MXG Vector Signal Generator 11/28/2018 Annual 11/28/2019 MY47420603 E4438C ESG Vector Signal Generator 3/11/2019 Biennial 3/11/2021 MY45090700 Agilent Amplifier Research 15S1G6 Amplifier N/A CBT* N/A 433978 ML2496A Power Meter 10/21/2018 10/21/2019 1138001 Anritsu Annual 11/20/2019 1339007 Anritsu MA2411B **Pulse Power Sensor** 11/20/2018 Annual Anritsu MA2411B **Pulse Power Sensor** 11/20/2018 Annual 11/20/2019 1339008 MA24106A 1/31/2019 1/31/2020 1520503 Anritsu **USB** Power Sensor Annual MA24106A **USB** Power Sensor 1/31/2019 1/31/2020 1520501 Anritsu Annual 2/28/2020 150761911 **Control Company** 4040 Temperature / Humidity Monitor 2/28/2018 Biennial CBT* Mini-Circuits NLP-1200+ Low Pass Filter DC to 1000 MHz N/A N/A N/A **Mini-Circuits** NLP-2950+ Low Pass Filter DC to 2700 MHz N/A CBT* N/A N/A **Mini-Circuits BW-N20W5** Power Attenuator N/A CBT* N/A 1226 PE2237-20 N/A CBT* N/A Pasternack **Bidirectional Coupler** N/A 8/3/2018 8/3/2019 140144 Rohde & Schwarz CMW500 Radio Communication tester Annual Rohde & Schwarz CMW500 Wideband Radio Communication Tester 1/30/2019 Annual 1/30/2020 162125 5/23/2018 5/23/2020 Seekonk NC-100 Torque Wrench (8" lb) Biennial N/A SPEAG Audio Interference Analzyer N/A CBT* N/A 1010 AIA EF3DV3 SPEAG Freespace E-field Probe 1/16/2019 1/16/2020 4035 Annual SPEAG DAE4 **Dasy Data Acquisition Electronics** 3/13/2019 Annual 3/13/2020 1415 CD835V3 SPEAG Freespace 835 MHz Dipole 2/19/2019 Biennial 2/19/2021 1003 CD1880V3 SPEAG Freespace 1880 MHz Dipole 2/19/2019 Biennial 2/19/2021 1137

Calibration traceable to the National Institute of Standards and Technology (NIST).

*Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

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12. MEASUREMENT UNCERTAINTY

Table 12-1

Uncertainty Estimation Table

Wireless Communications Device Near-Field Measurement Uncertainty Estimation							
	Data						
Uncertainty Component	(dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments
Measurement System	-	=				•	<u>.</u>
RF System Reflections	0.50	Tolerance	Ν	1.00	1	0.50	* Refl. < -20 dB
Field Probe Calibration	0.21	Tolerance	Ν	1.00	1	0.21	
Field Probe Isotropy	0.01	Tolerance	Ν	1.00	1	0.01	
Field Probe Frequency Response	0.135	Tolerance	Ν	1.00	1	0.14	
Field Probe Linearity	0.013	Tolerance	Ν	1.00	1	0.01	
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*
Resolution to 2mm error	0.21	Tolerance	Ν	1.00	1	0.21	
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*
Readout Electronics	0.015	Tolerance	Ν	1.00	1	0.02	*
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*
Response Time	0.033	Tolerance	R	1.73	1	0.02	*
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*
System Repeatability (Field x 2=power)	0.17	Tolerance	Ν	1.00	1	0.17	*
Test Sample Related		-					
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*
Power Drift	0.21	Tolerance	R	1.73	1	0.12	
Combined Standard Uncertainty (k=1)						0.66	16.3%
Expanded Uncertainty [95% confidence]						1.31	32.6%
Expanded Uncertainty [95% confidence] on Field						0.66	16.3%

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By combining the repeat measurements with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

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13. TEST DATA

See following Attached Pages for Test Data.

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Date: 7/8/2019



PCTEST Hearing-Aid Compatibility Facility

DUT: CD835V3 - SN1003

Type: CD835V3 Serial: 1003

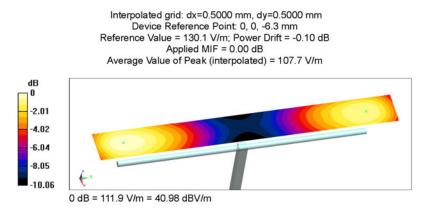
Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

835 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x361x1):



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PCTEST Hearing-Aid Compatibility Facility

DUT: CD1880V3 - SN1137

Type: CD1880V3 Serial: 1137

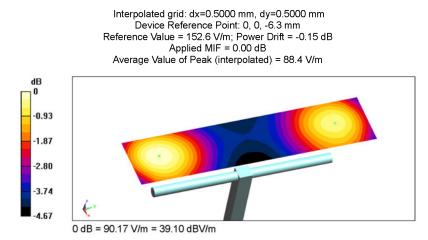
Communication System: CW; Frequency: 1880 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

1880 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):



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DUT: ZNFX120WM

Type: Portable Handset Serial: 04685 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 824.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

GSM850 Low Channel, Acoustic Centered Scan/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 77.85 V/m; Power Drift = 0.18 dB Applied MIF = 3.47 dB RF audio interference level = 38.91 dBV/m Emission category: M4

MIF scaled E-field

Grid 1 M	4 Grid	2 M4	Grid 3	M4
38.09 dE	3V/m 38.8	6 dBV/m	38.74	dBV/m
Grid 4 M	4 Grid	5 M4	Grid 6	M4
38.09 dE	3V/m 38.9	1 dBV/m	38.81	dBV/m
Grid 7 M	4 Grid	8 M4	Grid 9	M4
37.77 dE	3V/m 38.6	7 dBV/m	38.53	dBV/m



0 dB = 88.19 V/m = 38.91 dBV/m

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Date: 7/25/2019



DUT: ZNFX120WM

Type: Portable Handset Serial: 04685 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 1850.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- · Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

GSM1900 Low Channel, T-Coil Centered Scan/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 36.74 V/m; Power Drift = -0.11 dB Applied MIF = 3.53 dB RF audio interference level = 32.85 dBV/m Emission category: M3

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.94 dBV/m	30.61 dBV/m	31.51 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
28.65 dBV/m	32.29 dBV/m	32.84 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
27.65 dBV/m	32.38 dBV/m	32.85 dBV/m



0 dB = 43.92 V/m = 32.85 dBV/m

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14. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

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Calibration Laboratory of

PC Test

Client

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Certificate No:	EE3-4	035	an10
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CALIBRATION CERTIFICATE Object EF3DV3-SN:4035 Calibration procedure(s) QA CAL-02.v9, QA CAL-25.v7 Calibration procedure for E-field probes optimized for close near field evaluations in air /neft 2/11/2019 Calibration date: January 16, 2019 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID Cal Date (Certificate No.) Scheduled Calibration Power meter NRP SN: 104778 04-Apr-18 (No. 217-02672/02673) Apr-19 Power sensor NRP-Z91 SN: 103244 04-Apr-18 (No. 217-02672) Apr-19 Power sensor NRP-Z91 SN: 103245 04-Apr-18 (No. 217-02673) Apr-19 Reference 20 dB Attenuator SN: S5277 (20x) 04-Apr-18 (No. 217-02682) Apr-19 DAE4 SN: 789 14-Jan-19 (No. DAE4-789_Jan19) Jan-20 Reference Probe ER3DV6 SN: 2328 09-Oct-18 (No. ER3-2328_Oct18) Oct-19 Secondary Standards ID Check Date (in house) Scheduled Check Power meter E4419B SN: GB41293874 06-Apr-16 (in house check Jun-18) In house check: Jun-20 Power sensor E4412A SN: MY41498087 06-Apr-16 (in house check Jun-18) In house check: Jun-20 Power sensor E4412A SN: 000110210 06-Apr-16 (in house check Jun-18) In house check: Jun-20 RF generator HP 8648C SN: US3642U01700 04-Aug-99 (in house check Jun-18) In house check: Jun-20 Network Analyzer E8358A SN: US41080477 31-Mar-14 (in house check Oct-18) In house check: Oct-19 Name Function Signature Calibrated by: Manu Seitz Laboratory Technician Approved by: Katia Pokovic Technical Manager Issued: January 17, 2019

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Glossary:

NORMx,y,z DCP CF A, B, C, D En Ep	sensitivity in free space diode compression point crest factor (1/duty_cycle) of the RF signal modulation dependent linearization parameters incident E-field orientation normal to probe axis incident E-field orientation parallel to probe axis
Polarization φ	φ rotation around probe axis
Polarization &	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ = 0 for XY sensors and θ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no
 uncertainty required).

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DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
<u>Norm (μV/(V/m)²)</u>	0.90	0.74	1.20	± 10.1 %
DCP (mV) ^B	96.8	98.5	95.3	

Calibration results for Frequency Response (30 MHz - 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.3	76.8	-0.6%	77.3	0.1%	± 5.1 %
100	77.3	78.2	1.2%	77.8	0.7%	± 5.1 %
450	77.1	78.2	1.5%	77.8	0.9%	± 5.1 %
600	77.1	77.8	0.9%	77.5	0.5%	± 5.1 %
750	77.3	77.7	0.5%	77.2	-0.1%	± 5.1 %
1800	140.3	136.9	-2.4%	137.2	-2.2%	± 5.1 %
2000	133.0	129.4	-2.8%	129.4	-2.7%	± 5.1 %
2200	124.8	121.5	-2.7%	122.7	-1.7%	± 5.1 %
2500	123.7	120.7	-2.4%	121.9	-1.5%	± 5.1 %
3000	78.8	74.8	-5.0%	76.1	-3.5%	± 5.1 %
3500	256.3	248.1	-3.2%	246.0	-4.0%	± 5.1 %
3700	249.7	239.2	-4.2%	239.0	-4.3%	± 5.1 %
5200	50.7	50.7	-0.1%	51.2	0.9%	± 5.1 %
5500	49.6	48.9	-1.5%	48.7	-1.9%	± 5.1 %
5800	48.9	49.1	0.4%	49.3	0.8%	± 5.1 %

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Max dev.	Unc [⊭] (k=2)
0	CW	X	0.0	0.0	1.0	0.00	141.5	+ 3.3 %	±4.7 %
		Y	0.0	0.0	1.0		125.6		
		Y	0.0	0.0	1.0		125.1		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.
^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the

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EF3DV3 - SN:4035

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.28	0.21	5.68
Frequency Corr. (HF)	2.82	2.82	2.82

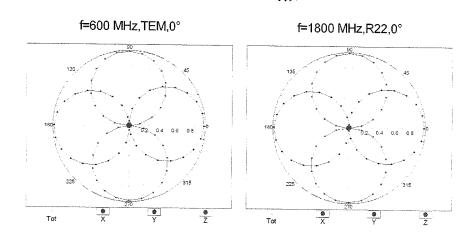
Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	57.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	335 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

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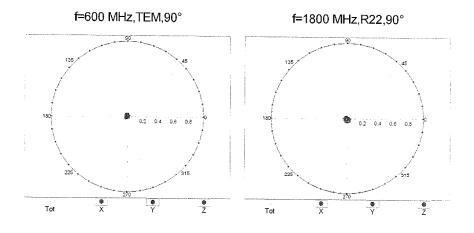
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Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$

Receiving Pattern (ϕ), ϑ = 90°

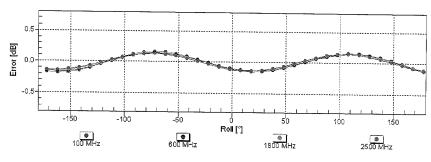


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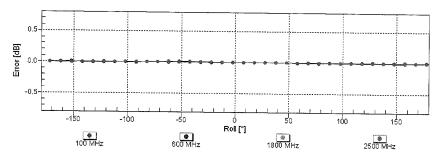
January 16, 2019



Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$

Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

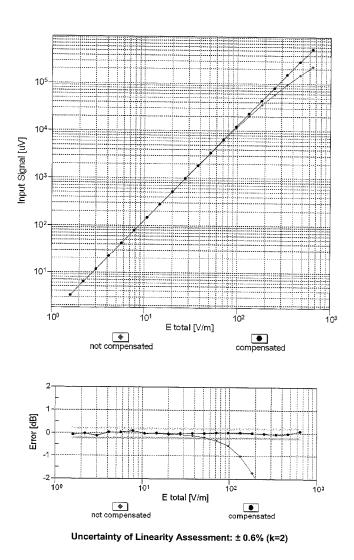
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EF3DV3 - SN:4035

January 16, 2019



Dynamic Range f(E-field) (TEM cell, f = 900 MHz)

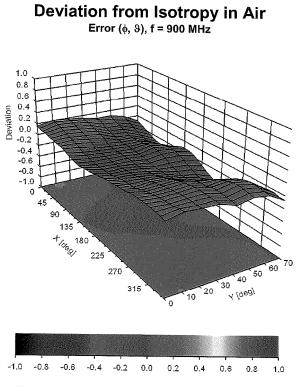
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EF3DV3 - SN:4035

January 16, 2019



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: EF3-4035_Jan19

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Client PC Test

Certificate No: CD835V3-1003_Feb19

Object	CD835V3 - SN:	1003	
Calibration procedure(s)	QA CAL-20.v7 Calibration Proc	edure for Validation Sources in a	ir VaA 3/19/2016
Calibration date:	February 19, 20	19	
All calibrations have been condu	ertainties with confidence p Icted in the closed laborato	ional standards, which realize the physical un probability are given on the following pages ar ny facility: environment temperature (22 \pm 3)%	nd are part of the certificate.
Calibration Equipment used (M& Primary Standards	1		
Power meter NRP	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power sensor NRP-Z91	SN: 104778	04-Apr-18 (No. 217-02672/02673)	Apr-19
ower sensor NRP-Z91	SN: 103244	04-Apr-18 (No. 217-02672)	Apr-19
Reference 20 dB Attenuator	SN: 103245	04-Apr-18 (No. 217-02673)	Apr-19
ype-N mismatch combination	SN: 5058 (20k)	04-Apr-18 (No. 217-02682)	Apr-19
robe EF3DV3	SN: 5047.2 / 06327	04-Apr-18 (No. 217-02683)	Apr-19
AE4	SN: 4013	03-Jan-19 (No. EF3-4013_Jan19)	Jan-20
//24	SN: 781	09-Jan-19 (No. DAE4-781_Jan19)	Jan-20
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
ower meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
ower sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20
ower sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
F generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-17)	In house check: Oct-20
	SN: US41080477	31-Mar-14 (in house check Oct-18)	In house check: Oct-19
		Function	Signature
	Name	FUNCTION	- P
letwork Analyzer HP 8358A alibrated by:	Name Claudio Leubler	Laboratory Technician	(17)
letwork Analyzer HP 8358A		which we want to the state of the	UA CEULS-

Certificate No: CD835V3-1003_Feb19

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 Approved by: Quality Manager

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 DUT Type: Portable Handset
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Accreditation No.: SCS 0108

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References

[1]

ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.2
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	105.2 V/m = 40.44 dBV/m	
Maximum measured above low end	100 mW input power	105.1 V/m = 40.43 dBV/m	
Averaged maximum above arm	100 mW input power	105.2 V/m ± 12.8 % (k=2)	

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance	
800 MHz	17.6 dB	40.4 Ω - 7.2 jΩ	
835 MHz	25.8 dB	52.2 Ω + 4.7 jΩ	
880 MHz	16.9 dB	62.1 Ω - 10.5 jΩ	
900 MHz	16.9 dB	52.2 Ω - 14.6 ϳΩ	
945 MHz	21.6 dB	51.8 Ω + 8.3 jΩ	

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot

le <u>Vi</u> ew <u>C</u> hannel Sw <u>e</u> ep Ca	Ibration Trace Scale	Marker System Window	v <u>H</u> elp		
10.00 (BS11) 5.00			1:	800.000000 MHz	-17.586 dB
			3:		25.837 dB -16.937 dB
0.00				380.000000 MH2	-16.937 dB
5.00			5	945 (00000 MHz	-21 641 dB
10.00					
15.00					
		52/			
20.00		-7. /9-4			
25.00					
30.00		<u> </u>			
35,00					
40,00 Ch1Avg= 20					
Ch1: Start 335.000 MHz		L		Stop	1.33500 GHz
Ch1: Start 335.000 MHz			3	Stop	1.33500 GHz
Ch1: Start 335.000 MHz			1:	Stop 800,000000 MHz	
Ch1: Start 335,000 MHz	la l			800.000000 MHz 27.676 pF	40.420 Ω -7.1883 Ω
Ch1: Start 335.000 MHz			1: >2:	800.000000 MH₂ 27.676 pF 835.000000 MH₂	40.420 Ω -7.1883 Ω 52.216 Ω
Ch1: Start 335.000 MHz			>2:	800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω
Ch1: Start 335.000 MHz				800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH 880.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω
Ch1: Start 335.000 MHz	Å		>2:	800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH 880.000000 MHz 17.263 pF	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω
Ch1: Start 335.000 MHz	Å		>2:	800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH 880.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω
Ch1: Start 335.000 MHz	<u> </u>		>2:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 880.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.00000 MHz	40.420 Ω -7.1983 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
Ch1: Start 335.000 MHz	Á		>2: 3: 4:	800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH 880.000000 MHz 17.283 pF 900.00000 MHz 12.080 pF	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω
Ch1: Start 335.000 MHz	<u> </u>		>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 880.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.00000 MHz	40.420 Ω -7.1983 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
Ch1: Start 335.000 MHz			>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 880.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.00000 MHz	40.420 Ω -7.1983 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
Ch1: Start 335.000 MHz			>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 880.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.00000 MHz	40.420 Ω -7.1983 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
Ch1: Start 335,000 MHz			>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 880.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.00000 MHz	40.420 Ω -7.1983 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
Ch I: Start 335.000 MHz Ch I Avg = 20 Ch I: Start 335.000 MHz			>2: 3: 4:	800.00000 MHz 27.676 pF 835.00000 MHz 902.00 pH 880.000000 MHz 17.263 pF 900.00000 MHz 12.80 pF 945.000000 MHz 1.3906 nH	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω

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DASY5 E-field Result

Date: 19.02.2019

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1003

 $\begin{array}{l} \mbox{Communication System: UID 0 - CW ; Frequency: 835 MHz} \\ \mbox{Medium parameters used: } \sigma = 0 \mbox{S/m}, \epsilon_r = 1; \mbox{ρ} = 0 \mbox{ kg/m}^3 \\ \mbox{Phantom section: } RF \mbox{Section} \\ \mbox{Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)} \end{array}$

DASY52 Configuration:

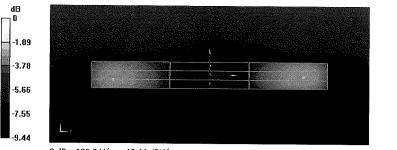
- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 03.01.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 09.01.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.2(1495); SEMCAD X 14.6.12(7450)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm

Reference Value = 127.3 V/m; Power Drift = 0.04 dB Applied MIF = 0.00 dB RF audio interference level = 40.44 dBV/m Emission category: M3

- -

MIF scaled E-fi	eld	
		Grid 3 M3 40.43 dBV/m
Grid 4 M4		Grid 6 M4
Grid 7 M3 40.15 dBV/m		Grid 9 M3 4 0.36 dBV/m



0 dB = 105.2 V/m = 40.44 dBV/m

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7/29/2019

Calibration Laboratory of

Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA



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Accreditation No.: SCS 0108

Multilateral Agreement for the recognition of calibration certificates Client PC Test Certificate No: CD1880V3-1137_Feb19 CALIBRATION CERTIFICATE Object CD1880V3 - SN: 1137 Calibration procedure(s) QA CAL-20.v7 Calibration Procedure for Validation Sources in air 3/19/201 Calibration date: February 19, 2019 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Calibration Power meter NRP SN: 104778 04-Apr-18 (No. 217-02672/02673) Apr-19 Power sensor NRP-Z91 SN: 103244 04-Apr-18 (No. 217-02672) Apr-19 Power sensor NRP-Z91 SN: 103245 04-Apr-18 (No. 217-02673) Apr-19 Reference 20 dB Attenuator SN: 5058 (20k) 04-Apr-18 (No. 217-02682) Apr-19 Type-N mismatch combination SN: 5047.2 / 06327 04-Apr-18 (No. 217-02683) Apr-19 Probe EF3DV3 SN: 4013 03-Jan-19 (No. EF3-4013_Jan19) Jan-20 DAE4 SN: 781 09-Jan-19 (No. DAE4-781_Jan19) Jan-20 Secondary Standards ID # Check Date (in house) Scheduled Check Power meter Agilent 4419B SN: GB42420191 09-Oct-09 (in house check Oct-17) In house check: Oct-20 Power sensor HP E4412A SN: US38485102 05-Jan-10 (in house check Oct-17) In house check: Oct-20 Power sensor HP 8482A SN: US37295597 09-Oct-09 (in house check Oct-17) In house check: Oct-20 RF generator R&S SMT-06 SN: 832283/011 27-Aug-12 (in house check Oct-17) In house check: Oct-20 Network Analyzer HP 8358A SN: US41080477 31-Mar-14 (in house check Oct-18) In house check: Oct-19 Name Function Calibrated by: Claudio Leubler Laboratory Technician Approved by: Katja Pokovic **Technical Manager** Issued: February 20, 2019 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Approved by: FCC ID: ZNFX120WM PCTEST HAC (RF EMISSIONS) TEST REPORT 🕞 LG Quality Manager Filename: Test Dates: DUT Type: Page 52 of 64 1M1907050113-07.ZNF 07/08/2019 - 07/25/2019 Portable Handset © 2019 PCTEST Engineering Laboratory, Inc. **REV 3.3.M**

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Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.2
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1730 MHz ± 1 MHz 1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	······································

Maximum Field values at 1730 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	95.0 V/m = 39.55 dBV/m
Maximum measured above low end	100 mW input power	94.9 V/m = 39.55 dBV/m
Averaged maximum above arm	100 mW input power	95.0 V/m ± 12.8 % (k=2)

Maximum Field values at 1880 MHz

.

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	88.9 V/m = 38.98 dBV/m
Maximum measured above low end	100 mW input power	86.6 V/m = 38.75 dBV/m
Averaged maximum above arm	100 mW input power	87.8 V/m ± 12.8 % (k=2)

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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Nominal Frequencies

Frequency	Return Loss	Impedance
1730 MHz	22.5 dB	54.4 Ω + 6.5 jΩ
1880 MHz	21.1 dB	55.9 Ω + 7.2 jΩ
1900 MHz	21.0 dB	59.0 Ω + 3.6 jΩ
1950 MHz	27.3 dB	53.0 Ω - 3.3 jΩ
2000 MHz	20.3 dB	42.4 Ω + 4.8 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot

	Calibration <u>Trace S</u> cale I	Window	Цер		
			1:	1.30000 GHz	-22,459 dB
2.00					21.146 dB
3.00			3:	1.900000 GHz	-21.0023B
8.00			4	1.950000 GHz	-27.332 dB
			713	2.000000.GHz	20 275 dB
13.00					
18.00 p					
23.00		40.	l l		
	I I I	7 3 13			
28,00	+				
33.00	<u> </u>	4∨			
38.00					
43.00 Ch 1 Avg = 20 Ch 1: Start 1.38000 GHz			1		
ALL OF THE PROPERTY AND A LESS AN				Stop	3 30000 CU
				Stop	2.38000 GHz
		×===>	1:	Stop : 1.730000 GHz	
	le la constance de la constance			1.730000 GHz 601.12 pH	54.408 Ω 6.5341 Ω
	K		1:	1.730000 GHz 601.12 pH 1.880000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω
			>2:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω
				1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω
			>2: 3:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900000 GHz 303.81 pH	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω
	Á		>2:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900600 GHz 303.81 pH 1.950000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω
	Ŕ		>2: 3: 4:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 24.752 pF	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω
			>2: 3:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 240.752 pF 2.000000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
	<u> </u>		>2: 3: 4:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 24.752 pF	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω
			>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 240.752 pF 2.000000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
			>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 240.752 pF 2.000000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
			>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 240.752 pF 2.000000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
Ch 1 Avg = 20			>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 240.752 pF 2.000000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
			>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 609.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz 24.752 pF 2.000000 GHz 383.29 pH	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
Ch 1 Avg ≈ 20	C 1-Port	Avg=20 Delay	>2: 3: 4:	1.730000 GHz 601.12 pH 1.880000 GHz 303.81 pH 1.950000 GHz 24.752 pF 2.000000 GHz 383.29 pH	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω 4.8166 Ω

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DASY5 E-field Result

Date: 19.02.2019

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1137

Communication System: UID 0 - CW ; Frequency: 1880 MHz, Frequency: 1730 MHz Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 1880 MHz, ConvF(1, 1, 1) @ 1730 MHz; Calibrated: 03.01.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 09.01.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.2(1495); SEMCAD X 14.6.12(7450)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 151.5 V/m; Power Drift = 0.02 dB Applied MIF = 0.00 dB RF audio interference level = 38.98 dBV/m Emission category: M2

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
38.55 dBV/m	38.98 dBV/m	38.93 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
35.71 dBV/m	35.97 dBV/m	35.96 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
38.31 dBV/m	38.75 dBV/m	38.73 dBV/m

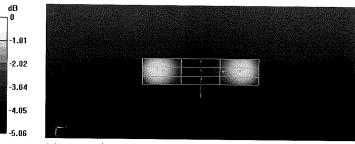
Certificate No: CD1880V3-1137_Feb19

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Dipole E-Field measurement @ 1880MHz /E-Scan - 1730MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 165.0 V/m; Power Drift = 0.03 dB Applied MIF = 0.00 dB RF audio interference level = 39.55 dBV/m Emission category: M2

	Grid 2 M2 39.55 dBV/m	Grid 3 M2 39.51 dBV/m
	Grid 5 M2	
36.57 dBV/m	36.95 dBV/m	36.95 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
39.05 dBV/m	39.55 dBV/m	39.53 dBV/m



0 dB = 88.87 V/m = 38.98 dBV/m

Certificate No: CD1880V3-1137_Feb19

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15. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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